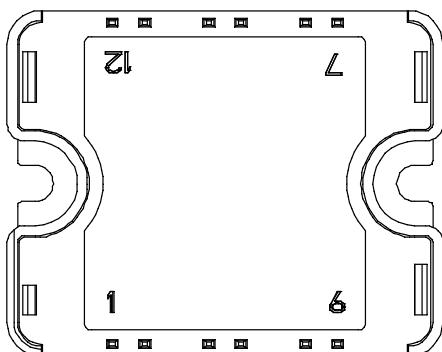
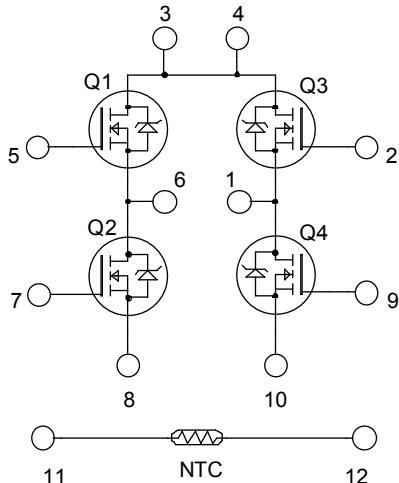


**Full - Bridge
Super Junction MOSFET
Power Module**

V_{DSS} = 800V
R_{DSon} = 290mΩ max @ T_j = 25°C
I_D = 15A @ T_c = 25°C



Pins 3/4 must be shorted together

Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V _{DSS}	Drain - Source Breakdown Voltage	800	V
I _D	Continuous Drain Current	T _c = 25°C	A
		T _c = 80°C	
I _{DM}	Pulsed Drain current	60	
V _{GS}	Gate - Source Voltage	±30	V
R _{DSon}	Drain - Source ON Resistance	290	mΩ
P _D	Maximum Power Dissipation	T _c = 25°C	W
I _{AR}	Avalanche current (repetitive and non repetitive)	17	A
E _{AR}	Repetitive Avalanche Energy	0.5	
E _{AS}	Single Pulse Avalanche Energy	670	mJ

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

All ratings @ $T_j = 25^\circ\text{C}$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0\text{V}$, $V_{DS} = 800\text{V}$	$T_j = 25^\circ\text{C}$			25	μA
		$V_{GS} = 0\text{V}$, $V_{DS} = 800\text{V}$	$T_j = 125^\circ\text{C}$			250	
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 10\text{V}$, $I_D = 7.5\text{A}$				290	$\text{m}\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 1\text{mA}$		2.1	3	3.9	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 20\text{ V}$, $V_{DS} = 0\text{V}$				± 100	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0\text{V}$ $V_{DS} = 25\text{V}$ $f = 1\text{MHz}$		2254			pF
C_{oss}	Output Capacitance			1046			
C_{rss}	Reverse Transfer Capacitance			54			
Q_g	Total gate Charge	$V_{GS} = 10\text{V}$ $V_{Bus} = 400\text{V}$ $I_D = 15\text{A}$		90			nC
Q_{gs}	Gate – Source Charge			11			
Q_{gd}	Gate – Drain Charge			45			
$T_{d(on)}$	Turn-on Delay Time	Inductive switching @ 125°C $V_{GS} = 15\text{V}$ $V_{Bus} = 533\text{V}$ $I_D = 15\text{A}$		10			ns
T_r	Rise Time			13			
$T_{d(off)}$	Turn-off Delay Time			83			
T_f	Fall Time			35			
E_{on}	Turn-on Switching Energy	Inductive switching @ 25°C $V_{GS} = 15\text{V}$, $V_{Bus} = 533\text{V}$ $I_D = 15\text{A}, R_G = 5\Omega$		243			μJ
E_{off}	Turn-off Switching Energy			139			
E_{on}	Turn-on Switching Energy	Inductive switching @ 125°C $V_{GS} = 15\text{V}$, $V_{Bus} = 533\text{V}$ $I_D = 15\text{A}, R_G = 5\Omega$		425			μJ
E_{off}	Turn-off Switching Energy			171			

Source - Drain diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_S	Continuous Source current (Body diode)		$T_c = 25^\circ\text{C}$		15		A
			$T_c = 80^\circ\text{C}$		11		
V_{SD}	Diode Forward Voltage	$V_{GS} = 0\text{V}$, $I_S = - 15\text{A}$				1.2	V
dv/dt	Peak Diode Recovery ①					6	V/ns
t_{rr}	Reverse Recovery Time	$I_S = - 15\text{A}$ $V_R = 400\text{V}$ $di_S/dt = 100\text{A}/\mu\text{s}$		$T_j = 25^\circ\text{C}$	550		ns
Q_{rr}	Reverse Recovery Charge			$T_j = 25^\circ\text{C}$	15		μC

 ① dv/dt numbers reflect the limitations of the circuit rather than the device itself.

 $I_S \leq - 15\text{A}$ $di/dt \leq 100\text{A}/\mu\text{s}$ $V_R \leq V_{DSS}$ $T_j \leq 150^\circ\text{C}$

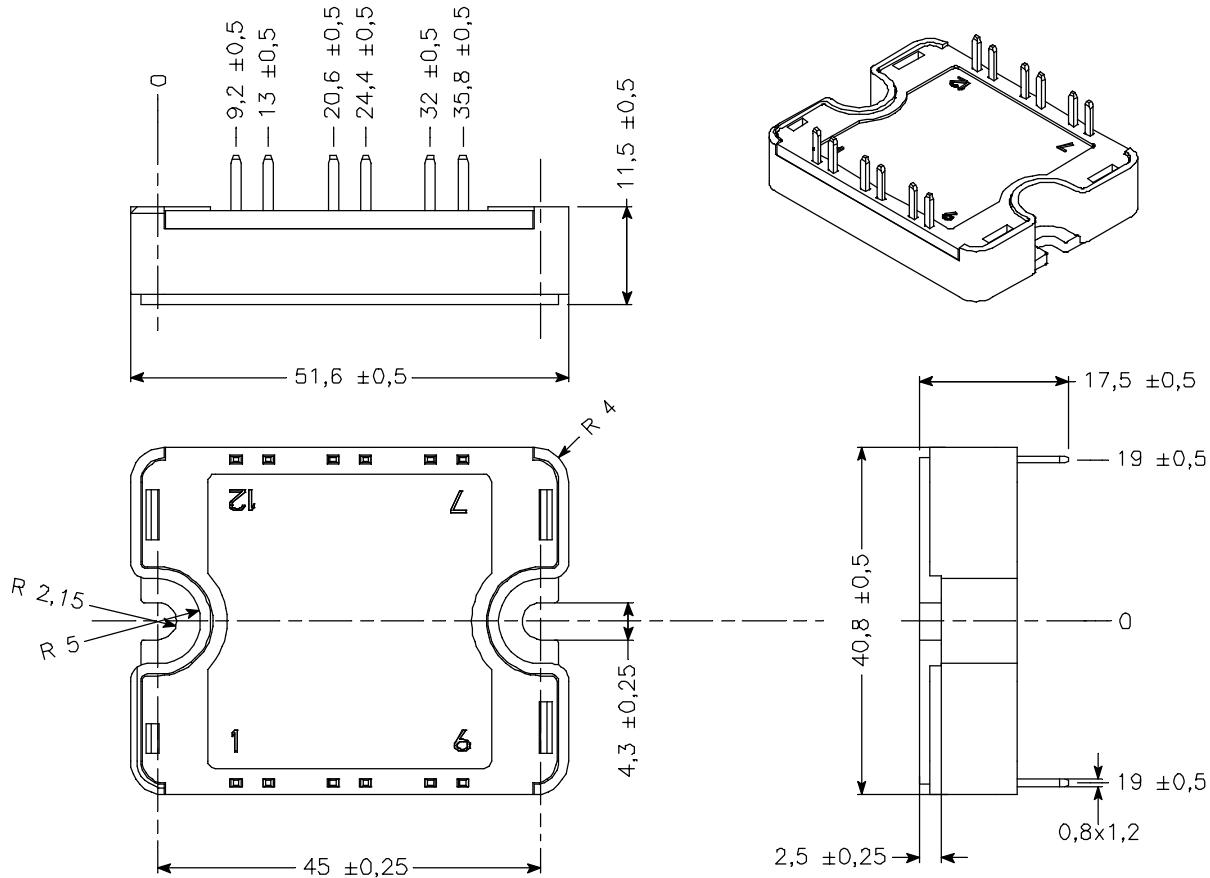
Thermal and package characteristics

Symbol	Characteristic		Min	Typ	Max	Unit
R _{thJC}	Junction to Case Thermal Resistance			0.80		°C/W
V _{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, I isol < 1mA, 50/60Hz	2500				V
T _J	Operating junction temperature range	-40		150		°C
T _{STG}	Storage Temperature Range	-40		125		
T _C	Operating Case Temperature	-40		100		
Torque	Mounting torque	To heatsink	M4	2.5	4.7	N.m
Wt	Package Weight			80		g

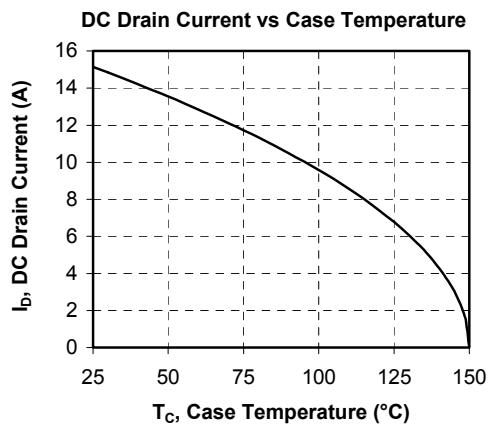
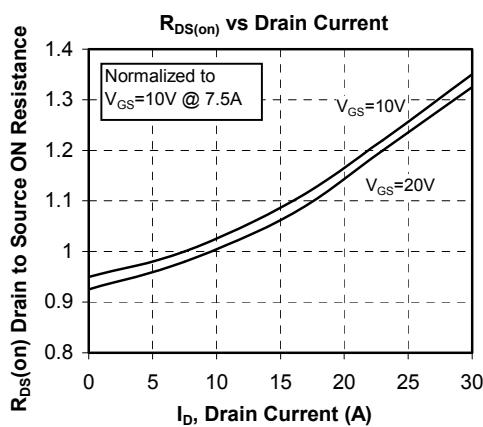
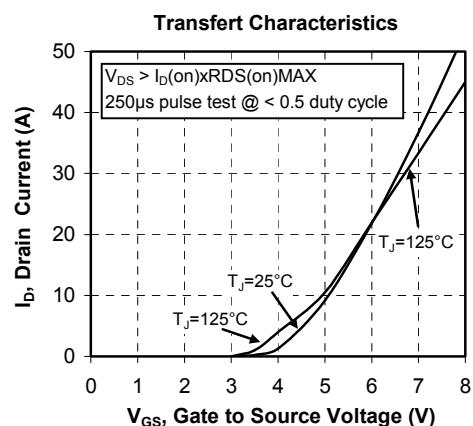
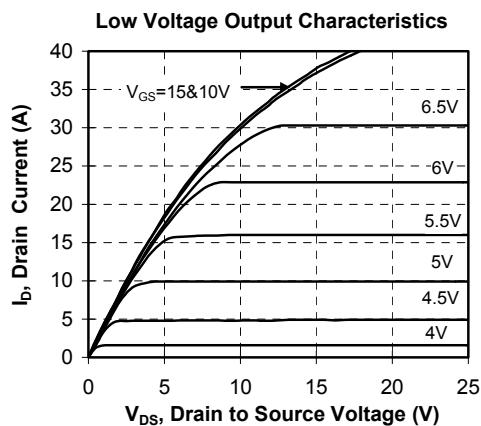
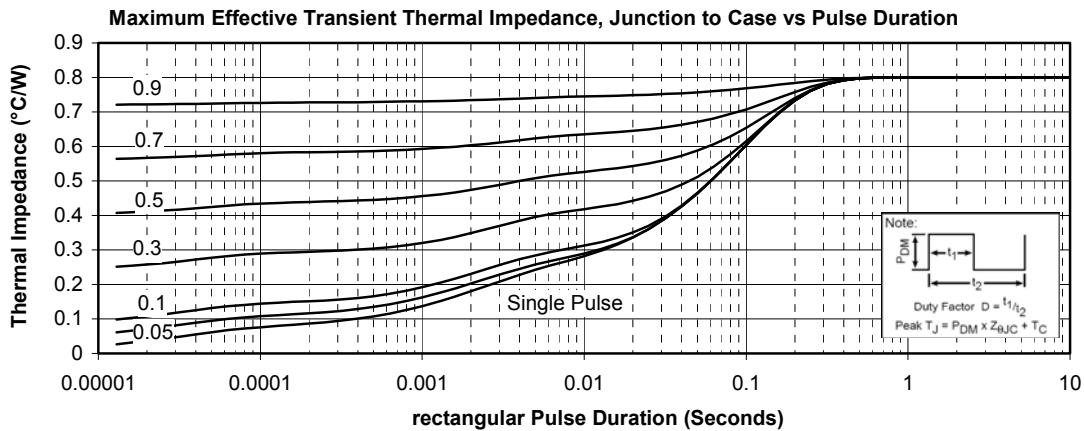
Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

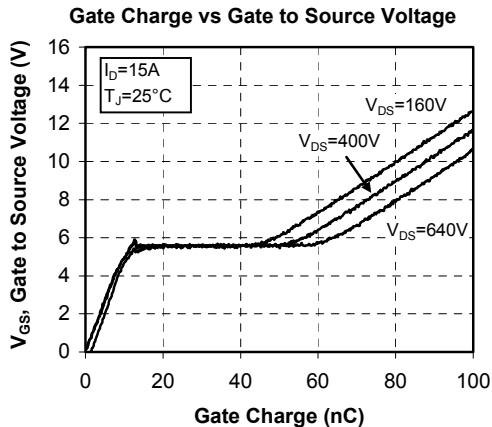
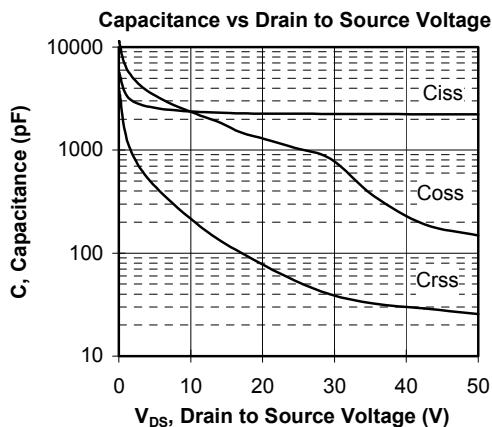
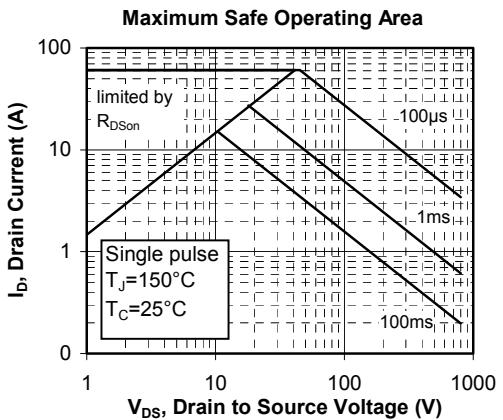
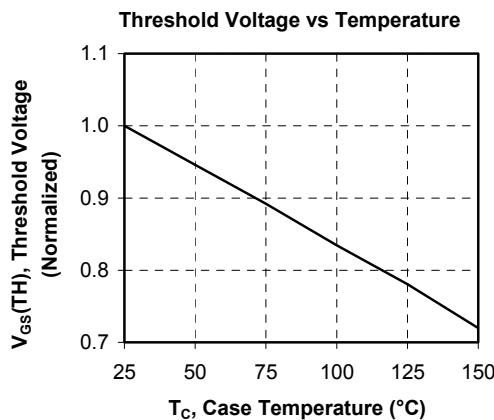
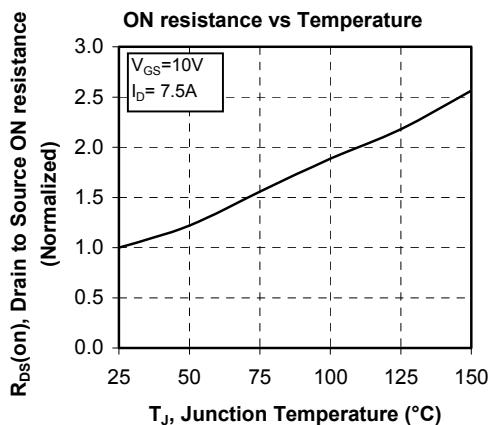
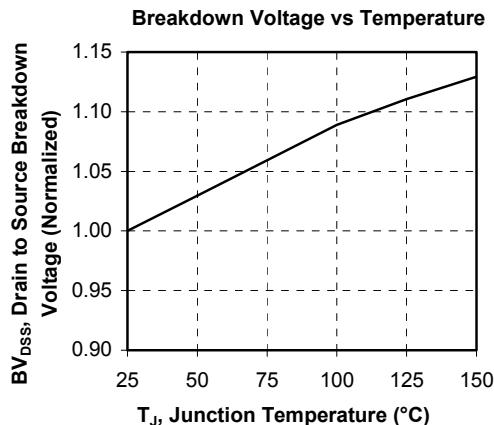
Symbol	Characteristic		Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
B _{25/85}	T ₂₅ = 298.15 K			3952		K

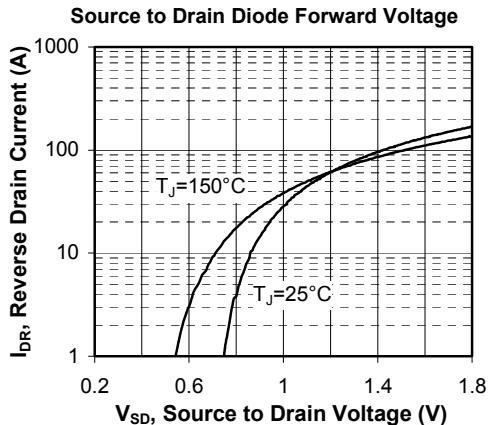
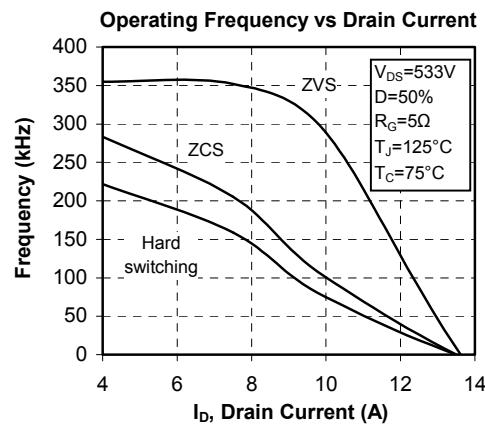
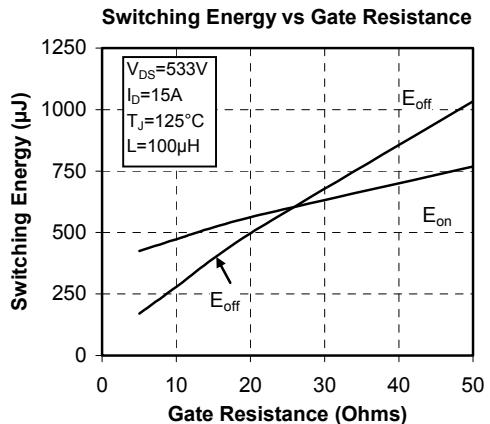
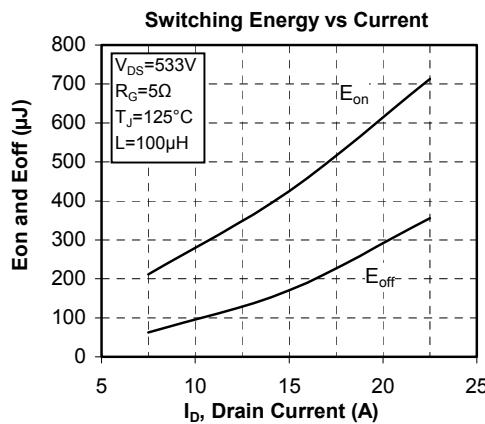
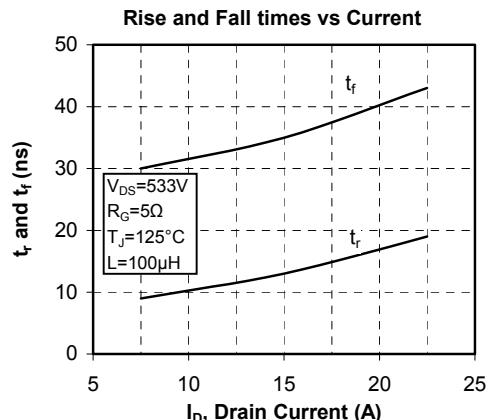
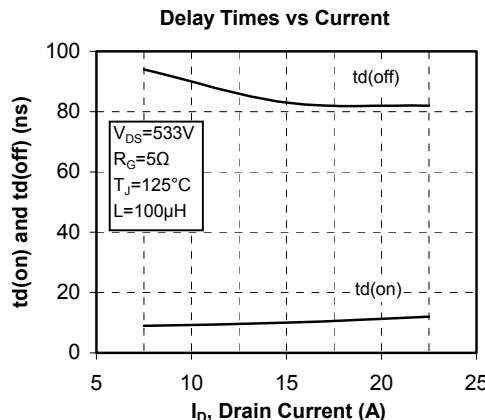
$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]} \quad T: \text{ Thermistor temperature} \\ R_T: \text{ Thermistor value at } T$$

SP1 Package outline (dimensions in mm)

 See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

Typical performance Curve







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